



UNITED STATES PATENT AND TRADEMARK OFFICE

UNITED STATES DEPARTMENT OF COMMERCE
 United States Patent and Trademark Office
 Address: COMMISSIONER FOR PATENTS
 P.O. Box 1450
 Alexandria, Virginia 22313-1450
 www.uspto.gov

BIB DATA SHEET

CONFIRMATION NO. 9761

SERIAL NUMBER	FILING or 371(c) DATE	CLASS	GROUP ART UNIT	ATTORNEY DOCKET NO.		
10/749,670	12/30/2003 RULE	356	2624	2522-047		
APPLICANTS Deok-Yong Kim, Gyeonggi-do, KOREA, REPUBLIC OF; Byoung-Ho Lee, Gyeonggi-do, KOREA, REPUBLIC OF; DR						
** CONTINUING DATA ***** DR						
** FOREIGN APPLICATIONS ***** REPUBLIC OF KOREA 2003-102 01/02/2003						
** IF REQUIRED, FOREIGN FILING LICENSE GRANTED ** 04/29/2004						
Foreign Priority claimed 35 USC 119(a-d) conditions met	<input checked="" type="checkbox"/> Yes <input type="checkbox"/> No <input checked="" type="checkbox"/> Yes <input type="checkbox"/> No	<input type="checkbox"/> Met after Allowance Initials	STATE OR COUNTRY KOREA, REPUBLIC OF	SHEETS DRAWINGS 10	TOTAL CLAIMS 27	INDEPENDENT CLAIMS 3
Verified and /MICHAEL A Acknowledged NEWMAN/ Examiner's Signature						
ADDRESS MARGER JOHNSON & MCCOLLOM, P.C. 210 SW MORRISON STREET, SUITE 400 PORTLAND, OR 97204 UNITED STATES						
TITLE Method and apparatus for detecting defects on a wafer						
FILING FEE RECEIVED 896	FEES: Authority has been given in Paper No. _____ to charge/credit DEPOSIT ACCOUNT No. _____ for following:			<input type="checkbox"/> All Fees		
				<input type="checkbox"/> 1.16 Fees (Filing)		
				<input type="checkbox"/> 1.17 Fees (Processing Ext. of time)		
				<input type="checkbox"/> 1.18 Fees (Issue)		
				<input type="checkbox"/> Other _____		
			<input type="checkbox"/> Credit			